

## **VBP15R50S Datasheet**

# N-Channel 500V(D-S) Super Junction Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	500				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 0.080				
Q <sub>g</sub> (Max.) (nC)	350				
Q <sub>gs</sub> (nC)	85				
Q <sub>gd</sub> (nC)	180				
Configuration	Single				

#### **FEATURES**

ullet Low Gate Charge  $\mathbf{Q}_{\mathbf{g}}$  Results in Simple Drive Requirement



- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Low R<sub>DS(on)</sub>
- Compliant to RoHS Directive 2002/95/EC



N-Channel MOSFET

### **APPLICATIONS**

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V <sub>DS</sub>	500	V			
Gate-Source Voltage			$V_{GS}$	± 30	V	
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$		40		
Continuous Drain Current	VGS at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	25	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	180		
Linear Derating Factor				4.3	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	910	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	40	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	51	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			$P_D$	530	W	
Peak Diode Recovery dV/dtc			dV/dt	9.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>		

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting  $T_J$  = 25 °C, L = 0.82 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 47 A (see fig. 12c).
- c.  $I_{SD} \le 47$  A,  $dI/dt \le 230$  A/µs,  $V_{DD} \le \tilde{V}_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS						
PARAMETER SYMBOL TYP. MAX. UNIT						
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.23			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 250 μA	500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I <sub>D</sub> = 1 mA	-	0.60	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 30 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		= 500 V, V <sub>GS</sub> = 0 V V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	50 250	μA
Drain-Source On-State Resistance	D	$V_{DS} = 400 \text{ V}$ $V_{GS} = 10 \text{ V}$	$I_D = 28 \text{ A}^b$		0.080	-	Ω
Forward Transconductance	R <sub>DS(on)</sub>		= 50 V, I <sub>D</sub> = 28 A	23	0.080	_	S
Dynamic Dynamic	9 <sub>fs</sub>	V DS	= 50 V, ID = 20 A	23			
Input Capacitance	C <sub>iss</sub>			_	8310	_	
Output Capacitance	C <sub>oss</sub>	-	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		960	_	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	.0 MHz, see fig. 5		120	_	
neverse transfer Capacitance	Orss		1 4 2 4 5 4 5 1 1		10170	_	рF
Output Capacitance	$C_{oss}$	V <sub>GS</sub> = 0 V	$V_{DS} = 1.0 \text{ V}, f = 1.0 \text{ MHz}$ $V_{DS} = 400 \text{ V}, f = 1.0 \text{ MHz}$	-	240	-	-
Effective Output Capacitance	C <sub>oss</sub> eff.	$V_{DS} = 0 \text{ V to } 400 \text{ V}^{c}$		-	440	-	1
Total Gate Charge	Qq			-	-	350	
Gate-Source Charge	Q <sub>gs</sub>	1	$I_D = 47 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	85	nC
Gate-Drain Charge	Q <sub>gd</sub>	1	See lig. o and 10	-	-	180	1
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>GS</sub> = 10 V	V <sub>GS</sub> = 10 V		25	-	ns
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 47 A,		-	140	-	
Turn-Off Delay Time	t <sub>d(off)</sub>		$V_{DD} = 250 \text{ V}, I_D = 47 \text{ A},$ $R_G = 1.0 \Omega, \text{ see fig. } 10^{\text{b}}$		55	-	
Fall Time	t <sub>f</sub>	1   1		-	74	-	
Drain-Source Body Diode Characteristic	s		<u> </u>				
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	47	^
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	190	- A
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 47 A, V <sub>GS</sub> = 0 V <sup>b</sup>		1	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 47 A, dl/dt = 100 A/μs <sup>b</sup>		-	620	940	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	14	21	μC
Body Diode Recovery Current	I <sub>RRM</sub>			-	38	-	Α
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )					12)

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  400  $\mu$ s; duty cycle  $\leq$  2 %. c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

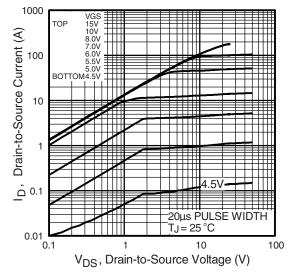
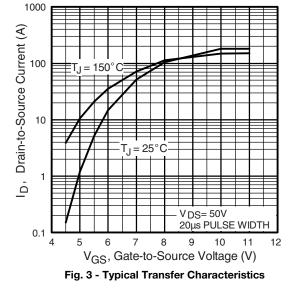


Fig. 1 - Typical Output Characteristics



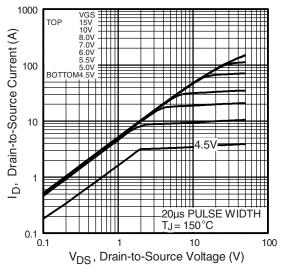


Fig. 2 - Typical Output Characteristics

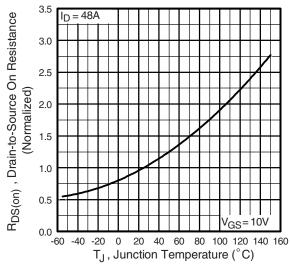


Fig. 4 - Normalized On-Resistance vs. Temperature

3



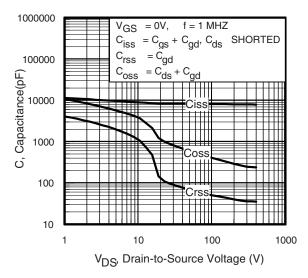


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

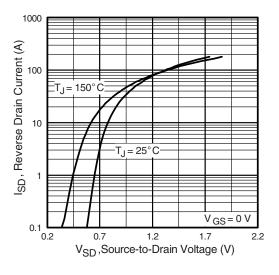


Fig. 7 - Typical Source-Drain Diode Forward Voltage

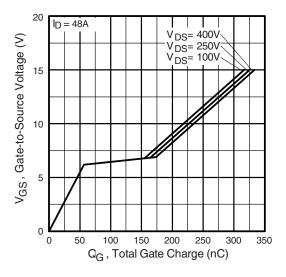


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

4

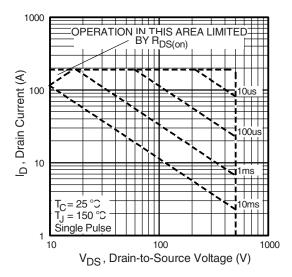


Fig. 8 - Maximum Safe Operating Area



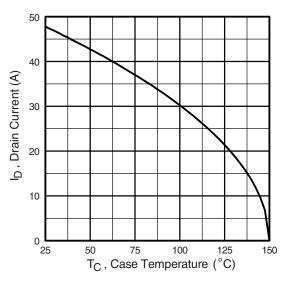


Fig. 9 - Maximum Drain Current vs. Case Temperature

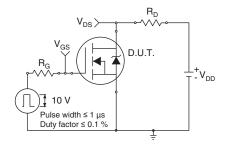


Fig. 10a - Switching Time Test Circuit

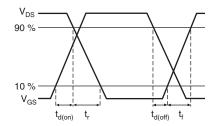


Fig. 10b - Switching Time Waveforms

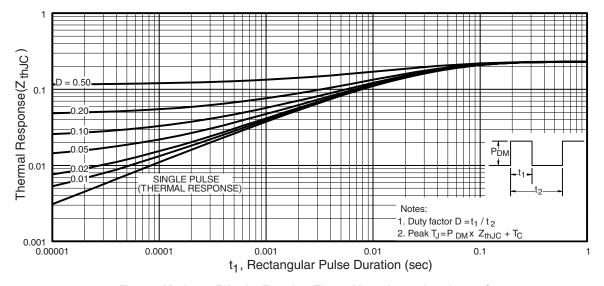
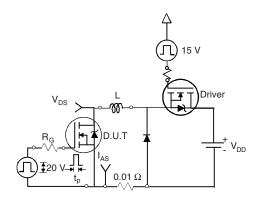


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





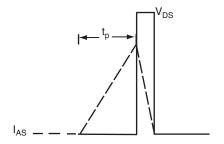


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

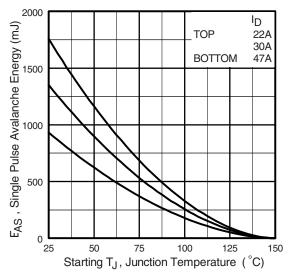


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

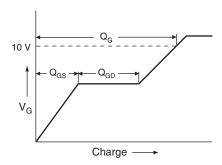


Fig. 13a - Basic Gate Charge Waveform

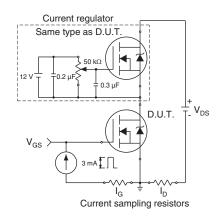
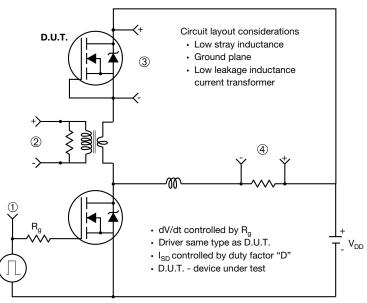


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



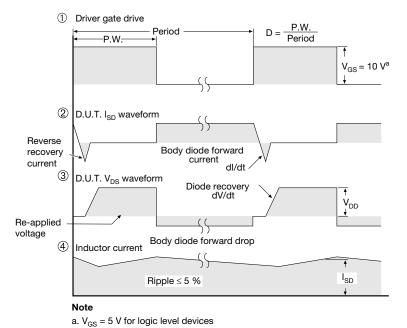
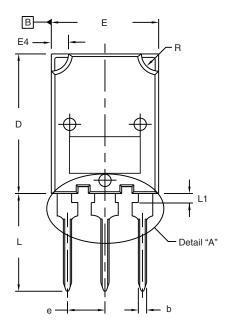
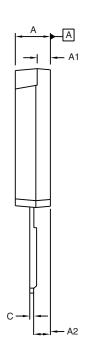


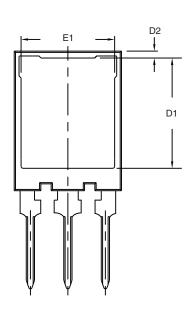
Fig. 14 - For N-Channel

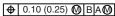


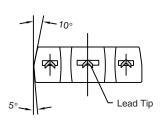
# **TO-274AA (High Voltage)**

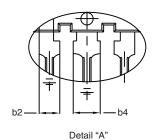












Scale: 2:1

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.70	5.30	0.185	0.209
A1	1.50	2.50	0.059	0.098
A2	2.25	2.65	0.089	0.104
b	1.30	1.60	0.051	0.063
b2	1.80	2.20	0.071	0.087
b4	3.00	3.25	0.118	0.128
c <sup>(1)</sup>	0.38	0.89	0.015	0.035
D	19.80	20.80	0.780	0.819

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	15.50	16.10	0.610	0.634
D2	0.70	1.30	0.028	0.051
Е	15.10	16.10	0.594	0.634
E1	13.30	13.90	0.524	0.547
е	5.45 BSC		0.215 BSC	
L	13.70	14.70	0.539	0.579
L1	1.00	1.60	0.039	0.063
R	2.00	3.00	0.079	0.118

ECN: X17-0056-Rev. B, 27-Mar-17

DWG: 5975

### Notes

- Dimensioning and tolerancing per ASME Y14.5M-1994
- Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outer extremes of the plastic body
- Outline conforms to JEDEC® outline to TO-274AA



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